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Application/Control No.	Applicant(s)/Patent under Reexamination
10/690,699	TSAI ET AL.
Examiner	Art Unit
Alex Liew	2624

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Class	Subclass	Date	Examiner
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Class	Subclass	Date	Examiner
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
East Text search	2/28/2007	AL	
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